

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		09/983,041	SHIBUYA, ATSUSHI	
Examiner		Art Unit		Page 1 of 1
Hai V. Nguyen		2142		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,111,043	09-2006	Kihara et al.	709/204
*	B	US-7,095,755	08-2006	Yamagishi, Yoichi	370/468
*	C	US-7,010,533	03-2006	Kutsumi et al.	707/10
*	D	US-6,993,555	01-2006	Kay et al.	709/202
*	E	US-6,882,793	04-2005	Fu et al.	386/95
*	F	US-6,850,259	02-2005	Rzepkowski et al.	715/835
*	G	US-6,778,194	08-2004	Jones, Steven Paul	715/808
*	H	US-6,628,311	09-2003	Fang, Chi	715/777
*	I	US-6,557,027	04-2003	Cragun, Brian John	709/204
*	J	US-6,583,799	06-2003	Manolis et al.	715/838
*	K	US-6,417,819	07-2002	Matsumoto et al.	345/1.1
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.